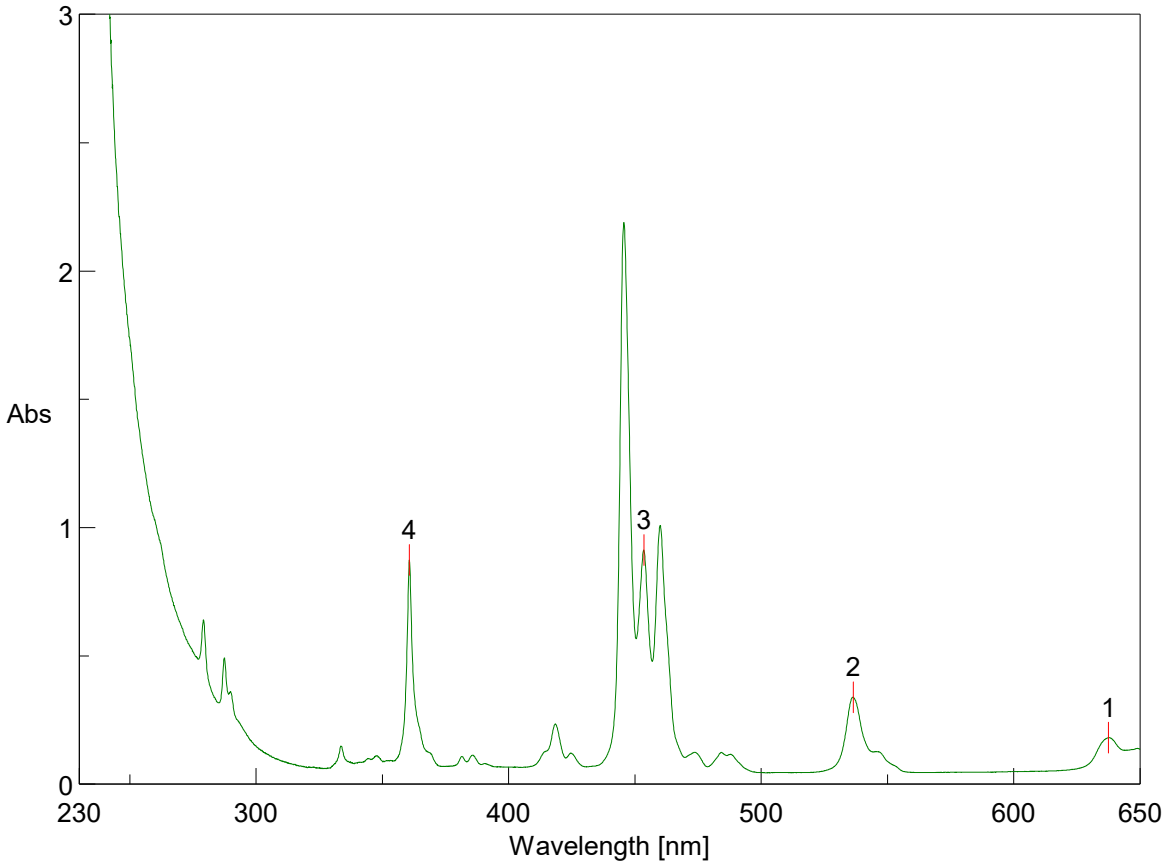
Peak Find - Exatidão Do Comprimento De Onda



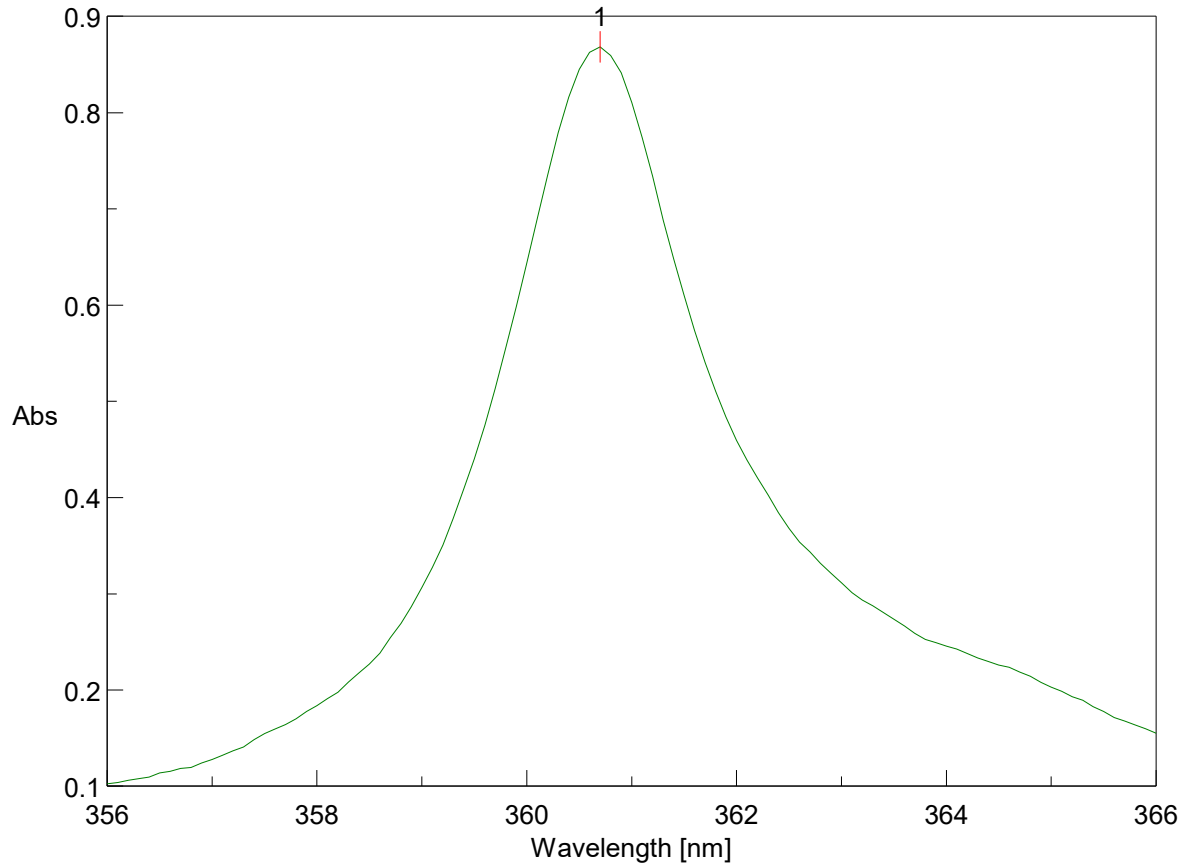
[Detailed Information]		[Measurement Information]	
Creation date	06/07/2023 10:05	Instrument name	UV/VIS
		Model name	V-660
Data array type	Linear data array	Serial No.	A013261152
Horizontal axis	Wavelength [nm]		
Vertical axis	Abs	Measurement date	06/07/2023 10:02
Start	650 nm		
End	230 nm	Parameter file	C:\CQ\Qualificação 2023\Exatidão
Data interval	0.1 nm	Do Comprimento De Onda.uvsp	
Data points	4201	Photometric mode	Abs
		Measurement range	650 - 230 nm
		Data interval	0.1 nm
			1.0 nm
		Response	Fast
		Scan speed	40 nm/min
		Change source at	340 nm
		Light source	D2/WI
		Filter exchange	Step
		Correction	None

[Result of Peak Picking]

No.	Position	Intensity	No.	Position	Intensity
1	637.5	0.181347	2	536.4	0.338546
3	453.5	0.912441	4	360.7	0.87276

Creation	QPack Soluções Analíticas Ltda
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Approval	

Peak Find - Repetibilidade Do Comprimento De Onda - Rep. 1



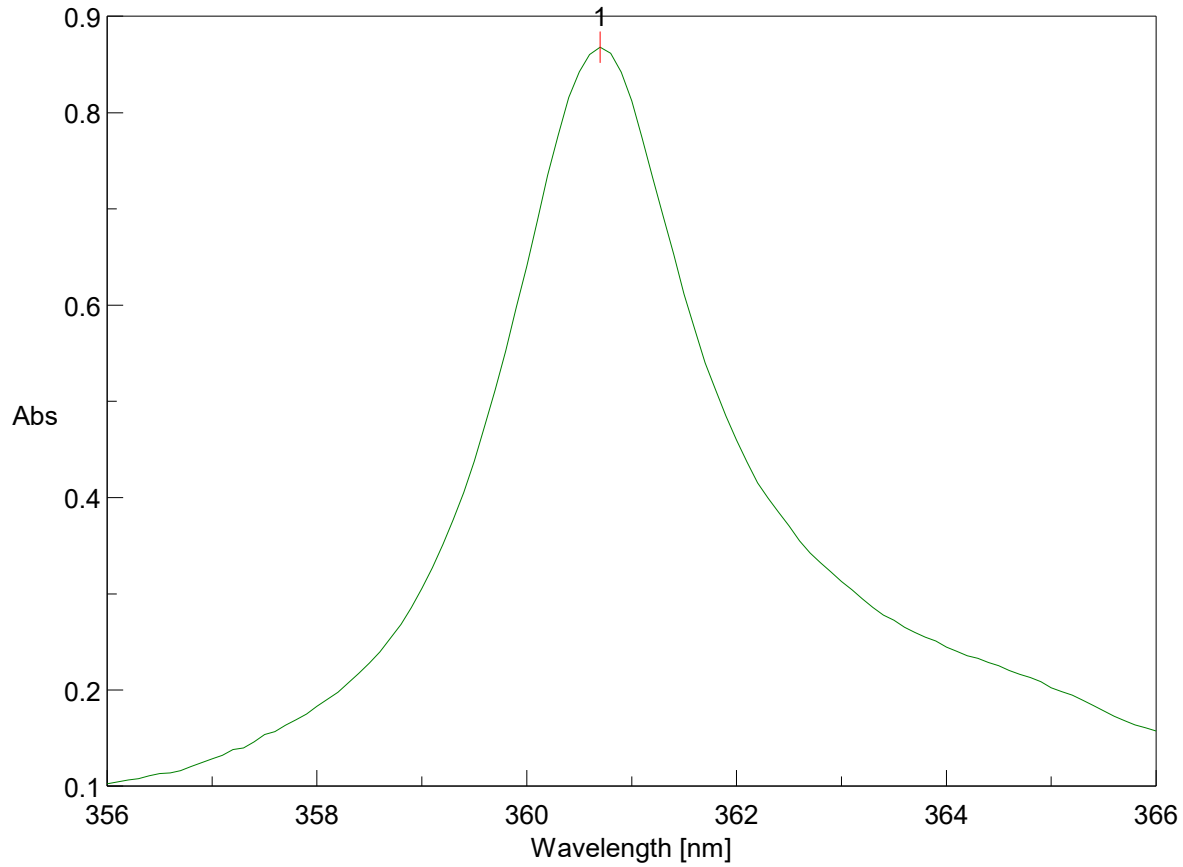
[Detailed Information]		[Measurement Information]	
Creation date	06/07/2023 10:09	Instrument name	UV/VIS
Date modified	06/07/2023 10:10	Model name	V-660
		Serial No.	A013261152
Data array type	Linear data array		
Horizontal axis	Wavelength [nm]	Measurement date	06/07/2023 10:08
Vertical axis	Abs		
Start	366 nm	Parameter file	C:\CQ\Qualificação
End	356 nm	2023\Repetibilidade Do Comprimento De Onda.uvsp	
Data interval	0.1 nm	Photometric mode	Abs
Data points	101	Measurement range	366 - 356 nm
		Data interval	0.1 nm
			1.0 nm
		Response	Fast
		Scan speed	40 nm/min
		Change source at	340 nm
		Light source	D2/WI
		Filter exchange	Step
		Correction	None

[Result of Peak Picking]

No.	Position	Intensity	No.	Position	Intensity
1	360.7	0.868118			

Creation	QPack Soluções Analíticas Ltda
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Peak Find - Repetibilidade Do Comprimento De Onda - Rep. 2



[Detailed Information]	
Creation date	06/07/2023 10:09
Date modified	06/07/2023 10:10
Data array type	Linear data array
Horizontal axis	Wavelength [nm]
Vertical axis	Abs
Start	366 nm
End	356 nm
Data interval	0.1 nm
Data points	101

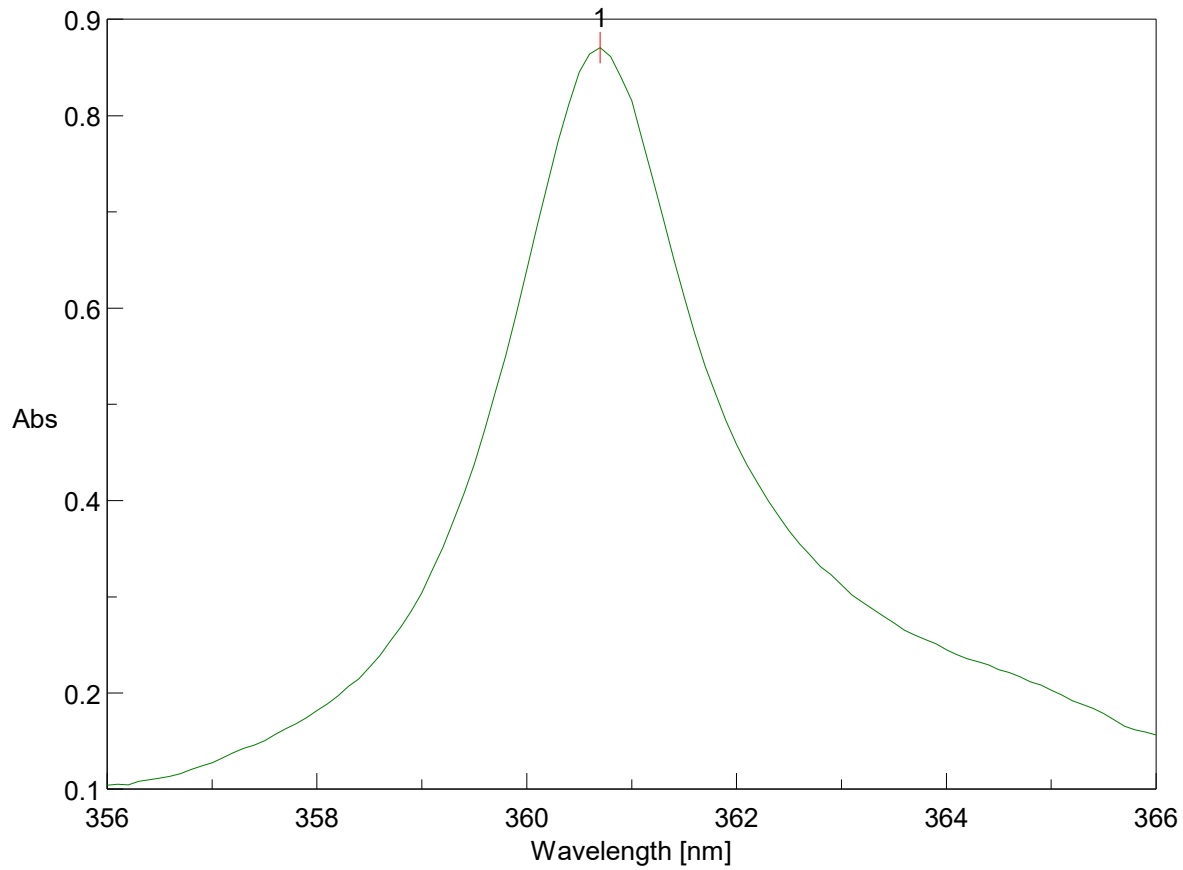
[Measurement Information]	
Instrument name	UV/VIS
Model name	V-660
Serial No.	A013261152
Measurement date	06/07/2023 10:08
Parameter file	C:\CQ\Qualificação 2023\Repetibilidade Do Comprimento De Onda.uvsp
Photometric mode	Abs
Measurement range	366 - 356 nm
Data interval	0.1 nm
	1.0 nm
Response	Fast
Scan speed	40 nm/min
Change source at	340 nm
Light source	D2/WI
Filter exchange	Step
Correction	None

[Result of Peak Picking]

No.	Position	Intensity	No.	Position	Intensity
1	360.7	0.8678			

Creation	QPack Soluções Analíticas Ltda
Review	
Approval	

Peak Find - Repetibilidade Do Comprimento De Onda - Rep. 3



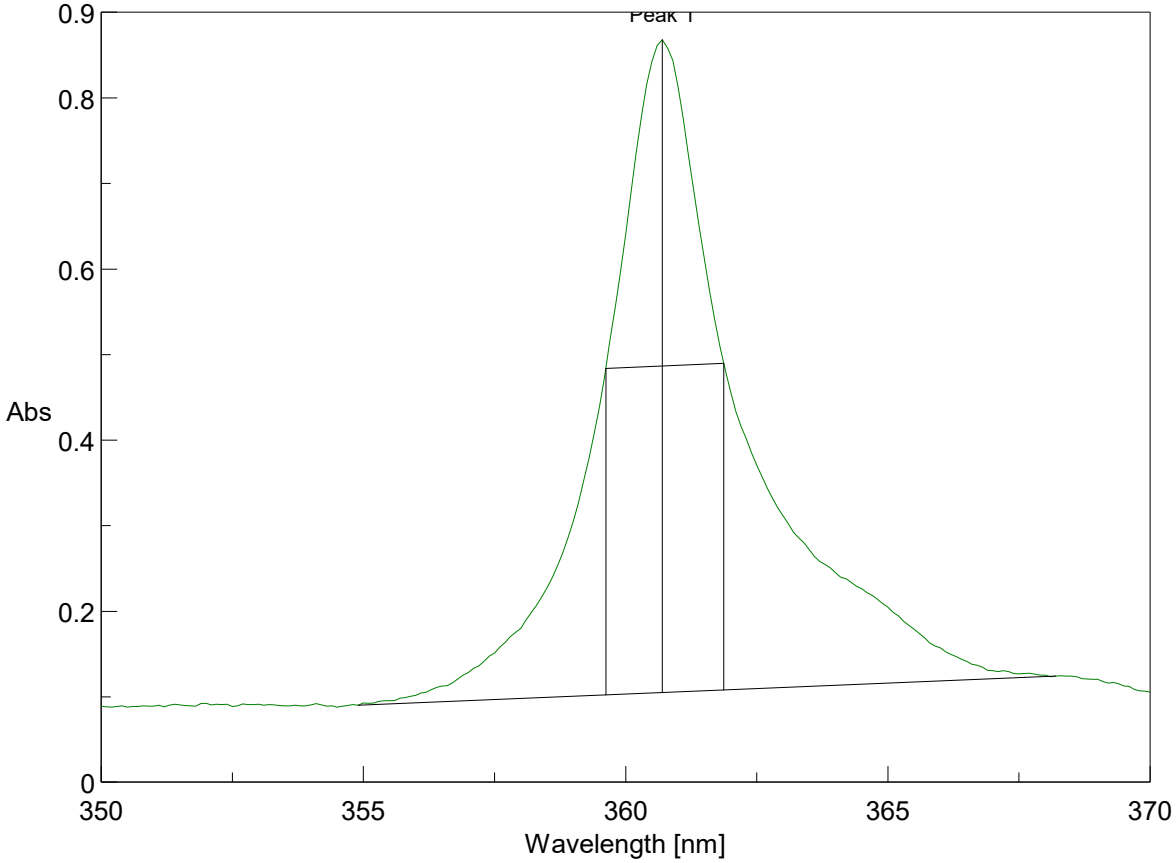
[Detailed Information]		[Measurement Information]	
Creation date	06/07/2023 10:09	Instrument name	UV/VIS
Date modified	06/07/2023 10:10	Model name	V-660
		Serial No.	A013261152
Data array type	Linear data array		
Horizontal axis	Wavelength [nm]	Measurement date	06/07/2023 10:09
Vertical axis	Abs		
Start	366 nm	Parameter file	C:\CQ\Qualificação
End	356 nm	2023\Repetibilidade Do Comprimento De Onda.uvsp	
Data interval	0.1 nm	Photometric mode	Abs
Data points	101	Measurement range	366 - 356 nm
		Data interval	0.1 nm
			1.0 nm
		Response	Fast
		Scan speed	40 nm/min
		Change source at	340 nm
		Light source	D2/WI
		Filter exchange	Step
		Correction	None

[Result of Peak Picking]

No.	Position	Intensity	No.	Position	Intensity
1	360.7	0.870351			

Creation	QPack Soluções Analíticas Ltda
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Full Width at Half Maximum - Resolução



[Result of FWHM Calculation]

Base 1	Base 2	Peak	Height	FWHM
354.9	368.2	360.7	0.763187	2.24942

[Comments]

Sample name	
Comment	
User	QPackSA
Workgroup	CQ
Division	Suporte Técnico
Company	Cristalia

[Detailed Information]

Creation date	06/07/2023 10:15
Date modified	06/07/2023 10:15
Data array type	Linear data array
Horizontal axis	Wavelength [nm]
Vertical axis	Abs
Start	370 nm
End	350 nm
Data interval	0.1 nm
Data points	201

[Measurement Information]

Instrument name	UV/VIS
Model name	V-660
Serial No.	A013261152
Measurement date	06/07/2023 10:14
Parameter file	C:\CQ\Qualificação 2023\Resolução.uvsp
Photometric mode	Abs
Measurement range	370 - 350 nm
Data interval	0.1 nm
	1.0 nm
Response	Fast
Scan speed	40 nm/min
Change source at	340 nm
Light source	D2/WI
Filter exchange	Step
Correction	None

Creation	QPack Soluções Analíticas Ltda
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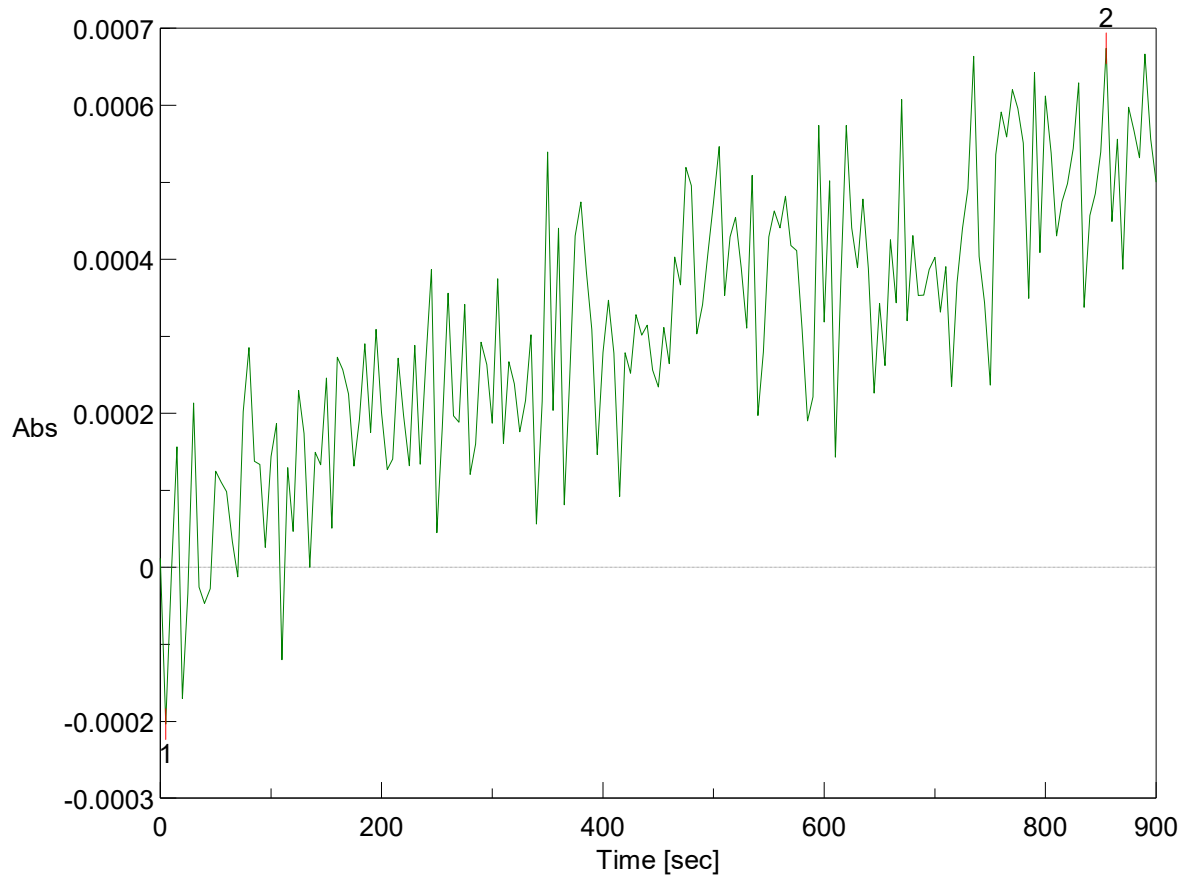
Sample name	
Comment	
User	QPackSA
Division	Suporte Técnico
Company	Cristalia
Creation date	06/07/2023 10:20
Instrument name	UV/VIS
Model name	V-660
Serial No.	A013261152
ROM version	1.16.00
Parameter file	C:\CQ\Qualificação 2023\Exatidão Fotométrica.uvfw
Photometric mode	Abs
	1.0 nm
Response	Medium
Wavelength-1	440.0 nm
Change source at	340 nm
Light source	D2/WI
Dark correction	Off

No.	Mode	Sample Name	Comment	440.0 nm
1	Sample-1	F2	06/07/2023 10:	0.2723
2	Sample-2	F3	06/07/2023 10:	0.5279
3	Sample-3	F4	06/07/2023 10:	1.1004

Sample name	
Comment	
User	QPackSA
Division	Suporte Técnico
Company	Cristalia
Creation date	06/07/2023 10:24
Instrument name	UV/VIS
Model name	V-660
Serial No.	A013261152
ROM version	1.16.00
Parameter file	C:\CQ\Qualificação 2023\Repetibilidade Fotométrica.uvfw
Photometric mode	Abs
	1.0 nm
Response	Medium
Wavelength-1	361.0 nm
Change source at	340 nm
Light source	D2/WI
Dark correction	Off

No.	Mode	Sample Name	Comment	361.0 nm
1	Sample-1	Rep. 1	06/07/2023 10:	0.7847
2	Sample-2	Rep. 2	06/07/2023 10:	0.7838
3	Sample-3	Rep. 3	06/07/2023 10:	0.7840

Peak Find - Estabilidade Da Linha De Base



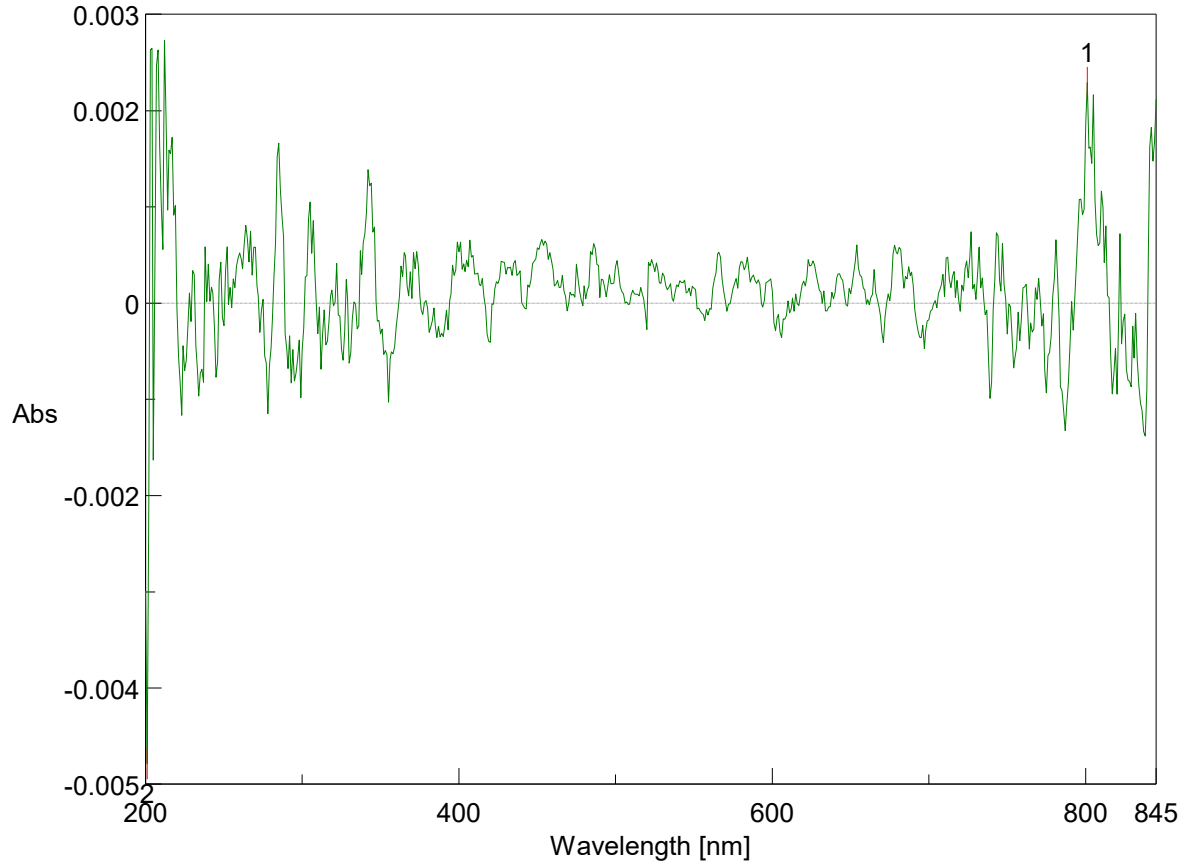
[Detailed Information]		[Measurement Information]	
Creation date	06/07/2023 10:41	Instrument name	UV/VIS
Date modified	06/07/2023 10:42	Model name	V-660
		Serial No.	A013261152
Data array type	Linear data array		
Horizontal axis	Time [sec]	Measurement date	06/07/2023 10:41
Vertical axis	Abs		
Start	0 sec	Parameter file	C:\CQ\Qualificação
End	900 sec	2023\Estabilidade Da Linha De Base.uvtm	
Data interval	5 sec	Photometric mode	Abs
Data points	181	Measurement range	0 - 900 sec
		Data interval	5 sec
		UV/Vis bandwidth	2.0 nm
		Response	Slow
		Monitor wavelength	250 nm
		Change source at	340 nm
		Light source	D2/WI
		Correction	Blank

[Result of Peak Picking]

No.	Position	Intensity	No.	Position	Intensity
1	5	-0.000204067	2	855	0.000673629

Creation	QPack Soluções Analíticas Ltda
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Approval	

Peak Find - Uniformidade Da Linha De Base



[Detailed Information]	
Creation date	06/07/2023 10:53
Date modified	06/07/2023 10:57
Data array type	Linear data array
Horizontal axis	Wavelength [nm]
Vertical axis	Abs
Start	900 nm
End	200 nm
Data interval	1 nm
Data points	701

[Measurement Information]	
Instrument name	UV/VIS
Model name	V-660
Serial No.	A013261152
Measurement date	06/07/2023 10:49
Parameter file	C:\CQ\Qualificação 2023\Uniformidade Da Linha De Base.uvsp
Photometric mode	Abs
Measurement range	900 - 200 nm
Data interval	1 nm
	1.0 nm
Response	Medium
Scan speed	400 nm/min
Change source at	340 nm
Light source	D2/WI
Filter exchange	Step
Correction	Baseline

[Result of Peak Picking]

No.	Position	Intensity	No.	Position	Intensity
1	801	0.00228755	2	201	-0.004788

Creation QPack Soluções Analíticas Ltda
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